Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/798,277	MAEDE ET AL.	
Examiner	Art Unit	
Trinh Vo Dinh	2821	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
315	169.1	10/31/2005	T.D	
345	204	V	V	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East search (US,UPGPUB,EPO,IBM,JPO,DERWE NT) 315/169.1, 169.3, 169.4 345/76,77, 84, 204, 214 (See search history printout)	7/20/2005	T.D
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